

Search Notes

Application/Control No.

10/604,048

Examiner

Benjamin C. Lee

Applicant(s)/Patent under
Reexamination

GIBEAU, JOHN

Art Unit

2612

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
340	425.5 686.6	4/27/2006	BCL
	539.11	↓	↓
	539.22	↓	↓
455	569.2	↓	↓

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (Text search history printout)	4/27/2006	BCL